

Key Parameters

V_{DS}	1200 V
I_D @ 25°C	60 A
R_{DS(on)}	13mΩ

ANC013P120ST

Silicon Carbide Power MOSFET
N- Channel Enhancement Mode

Features

产品特点

- | | |
|----------|--------------------------|
| ● 高开关频率 | High Switching Frequency |
| ● 低开关损耗 | Low Switching Loss |
| ● 软、快速开关 | Soft, fast Switching |
| ● 易并联使用 | Easy Paralleling |

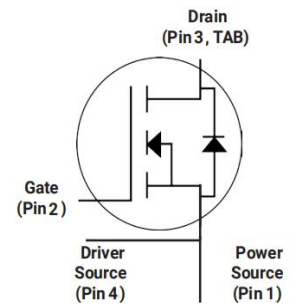
Benefits

- Higher System Efficiency
- Reduced Cooling Requirements
- Increased Power Density
- Increased System Switching Frequency

Applications

- Solar Inverters
- Switch Mode Power Supplies
- High Voltage DC/DC Converters
- Motor Drivers
- Pulsed Power Applications

Package



Part Number	Package
ANC013P120S	SOT-227

最大额定值

Maximum Ratings

符号 Symbol	参数名称 Parameter	测试条件 Test Conditions	数值 Value	单位 Unit
V _{DSmax}	漏源极电压 Drain-source voltage		1200	V
V _{GSS}	栅源峰值电压 Gate-source voltage		-5/+18	V
I _D	持续正向电流, 由 T _{vj max} 限制 Continuous forward current, limited by T _{vj max}		60	A
I _{DM}	最大重复正向电流, 由 T _{vj max} 限制 Maximum repetitive forward current, limited by T _{vj max}		120	A
T _{vj max}	最大允许结温 Max. Junction temperature		175	°C

$T_{vj(op)}$	工作结温 Operation junction temperature		-55...+175	°C
T_{Proc}	最大加工温度 Maximum processing temperature	最长持续时间 10min 10min, maximum	325	°C

电特性值

Electrical Characteristics

除非特别声明, 否则 $T_{vj} = 25\text{ °C}$ $T_{vj} = 25\text{ °C}$ unless otherwise stated

符号 Symbol	参数名称 Parameter	测试条件 Test Conditions	最小值 Min.	典型值 Typ.	最大值 Max.	单位 Unit
I_{DSS}	零栅压漏极电流 Zero gate voltage drain current	$V_{GS} = 0V, V_{DS} = V_{DSS}$			10	uA
I_{GSS}	栅极漏电流 Gate leakage current	$V_{GS} = V_{GSS}, V_{DS} = 0V$			100	nA
$V_{GS(th)}$	栅极-源极阈值电压 Gate threshold voltage	$I_D = 10\text{ mA}, V_{GS} = V_{DS}$	1.8	2.4	3.0	V
$R_{DS(on)}$	漏极-源极通态电阻 Drain-source on-state resistance	$V_{GS} = 15V, I_D = 60A$		13		m
		$V_{GS} = 15V, I_D = 60A, T_{vj} = 175\text{ °C}$		20		m
g_{fs}	跨导 Forward transconductance	$V_{DS} = 20V, I_D = 60A$		23		S
C_{iss}	输入电容 Input capacitance	$V_{DS} = 1000V, V_{GS} = 0V,$ $f = 100kHz, V_{AC} = 30mV$		4050		pF
C_{oss}	输出电容 Output capacitance			195		pF
C_{rSS}	反向传输电容 Reverse transfer capacitance			20		pF
E_{oss}	电容存储能量 Coss Stored Energy				230	
R_{Gint}	内部栅极电阻 Internal gate resistor			4		
Q_{GS}	栅源电荷 Gate to source charge	$I_D = 60A, V_{DS} = 800V, V_{GS} = -4/+15V$		57		nC
Q_{GD}	栅漏电荷 Gate to drain charge			80		nC
Q_G	总栅极电荷 Total gate charge			178		nC
V_{SD}	二极管正向电压 Diode forward voltage	$I_{SD} = 30A, V_{GS} = -4V$		5.0		V
		$I_{SD} = 30A, V_{GS} = -4V, T_{vj} = 175\text{ °C}$		4.6		V

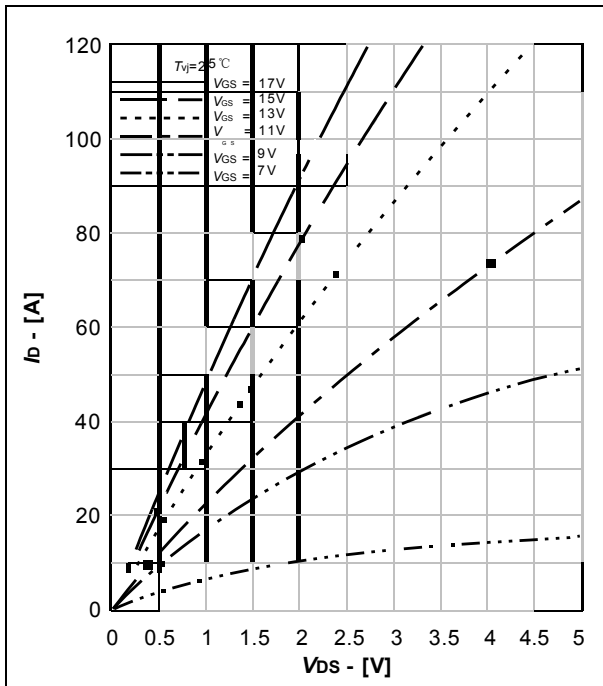

 图 2. 输出特性典型曲线, $I_D = f(V_{DS})$, $T_{vj} = 25\text{ }^\circ\text{C}$

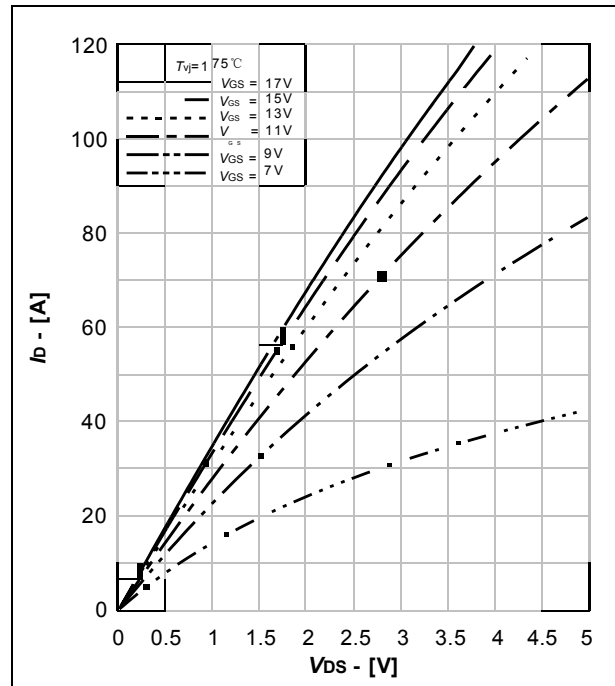
 Fig.2 Typical output characteristics, $I_D = f(V_{DS})$, $T_{vj} = 25\text{ }^\circ\text{C}$

 图 3. 输出特性典型曲线, $I_D = f(V_{DS})$, $T_{vj} = 175\text{ }^\circ\text{C}$

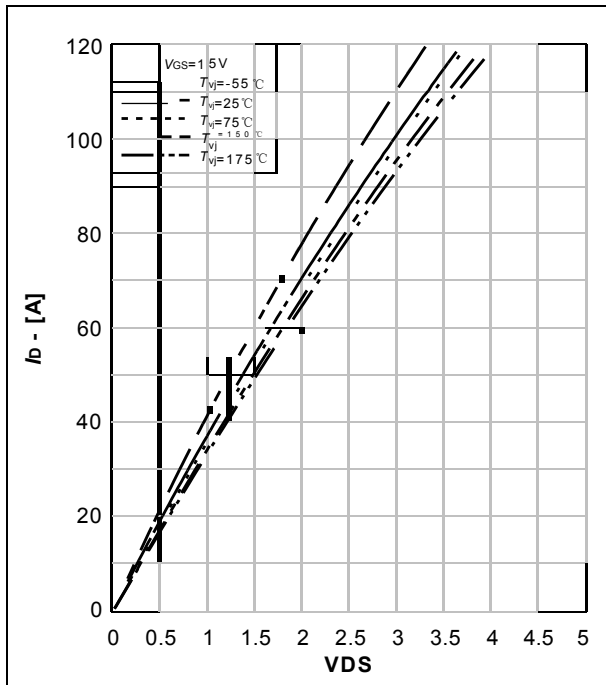
 Fig.3 Typical output characteristics, $I_D = f(V_{DS})$, $T_{vj} = 175\text{ }^\circ\text{C}$

 图 4. 输出特性典型曲线, $I_D = f(V_{DS})$

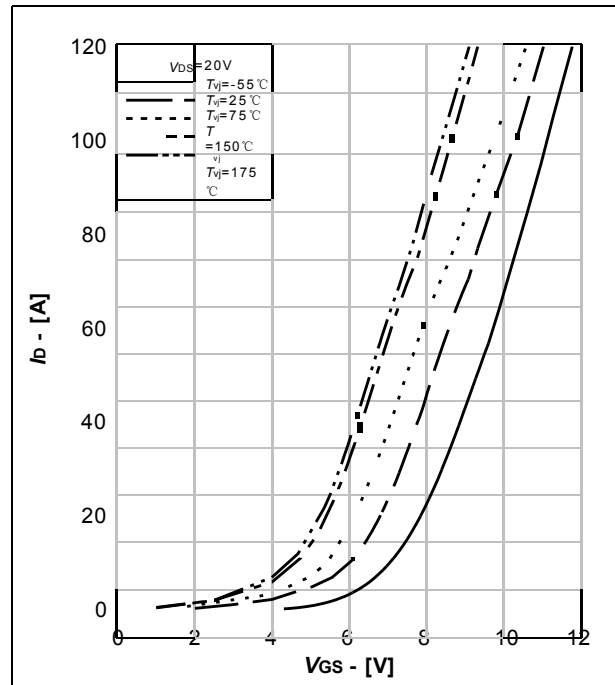
 Fig.4 Typical output characteristics, $I_D = f(V_{DS})$

 图 5. 传输特性典型曲线, $I_D = f(V_{GS})$

 Fig.5 Typical transfer characteristics, $I_D = f(V_{GS})$

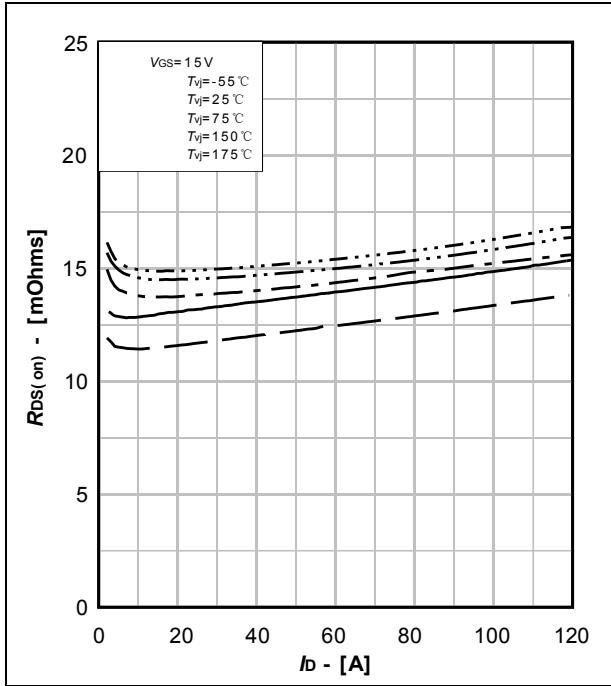

 图 6. 导通电阻典型曲线, $R_{DS(on)} = f(I_D)$

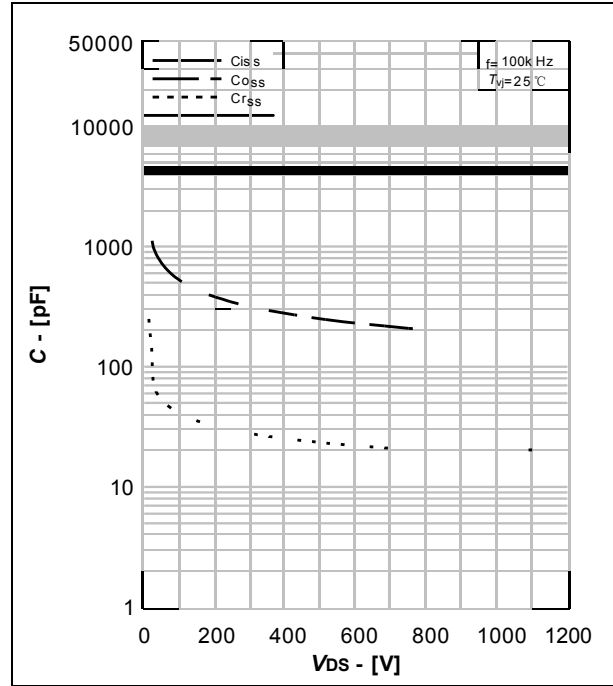
 Fig.6 Typical On-Resistance characteristics, $R_{DS(on)} = f(I_D)$

 图 7. 电容特性典型曲线, $C = f(V_{DS})$

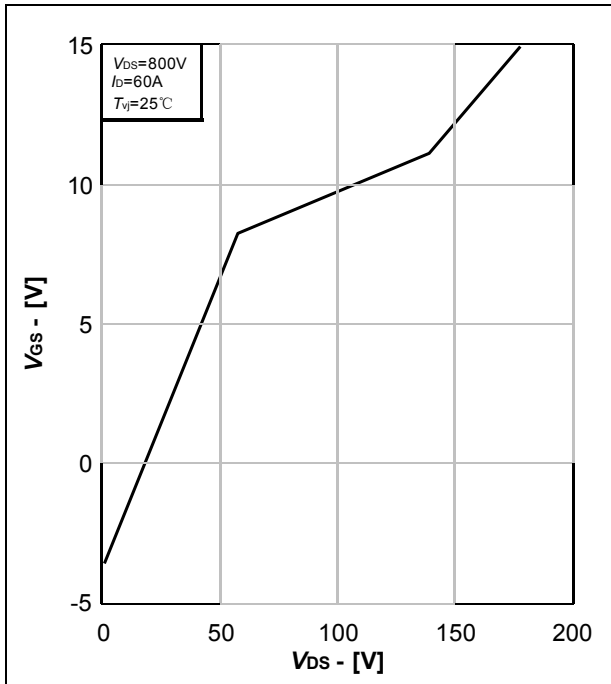
 Fig.7 Typical capacity characteristic, $C = f(V_{DS})$

 图 8. 栅极电荷特性典型曲线, $V_{GS} = f(Q_G)$

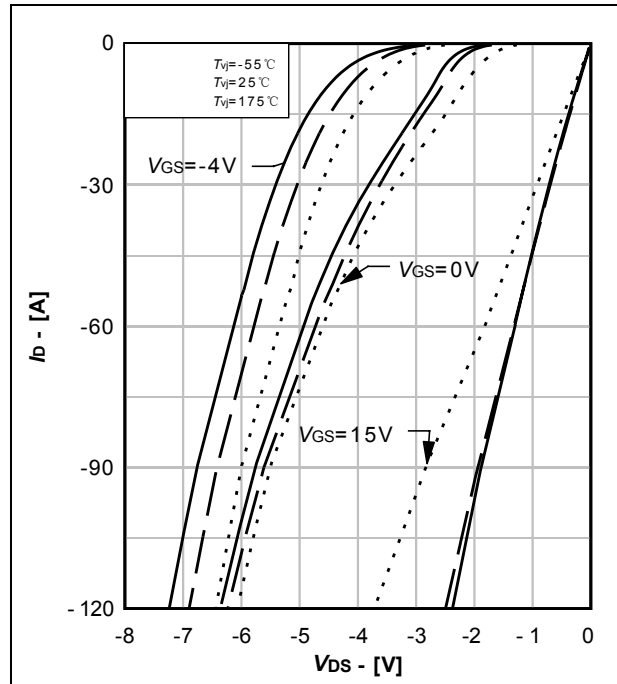
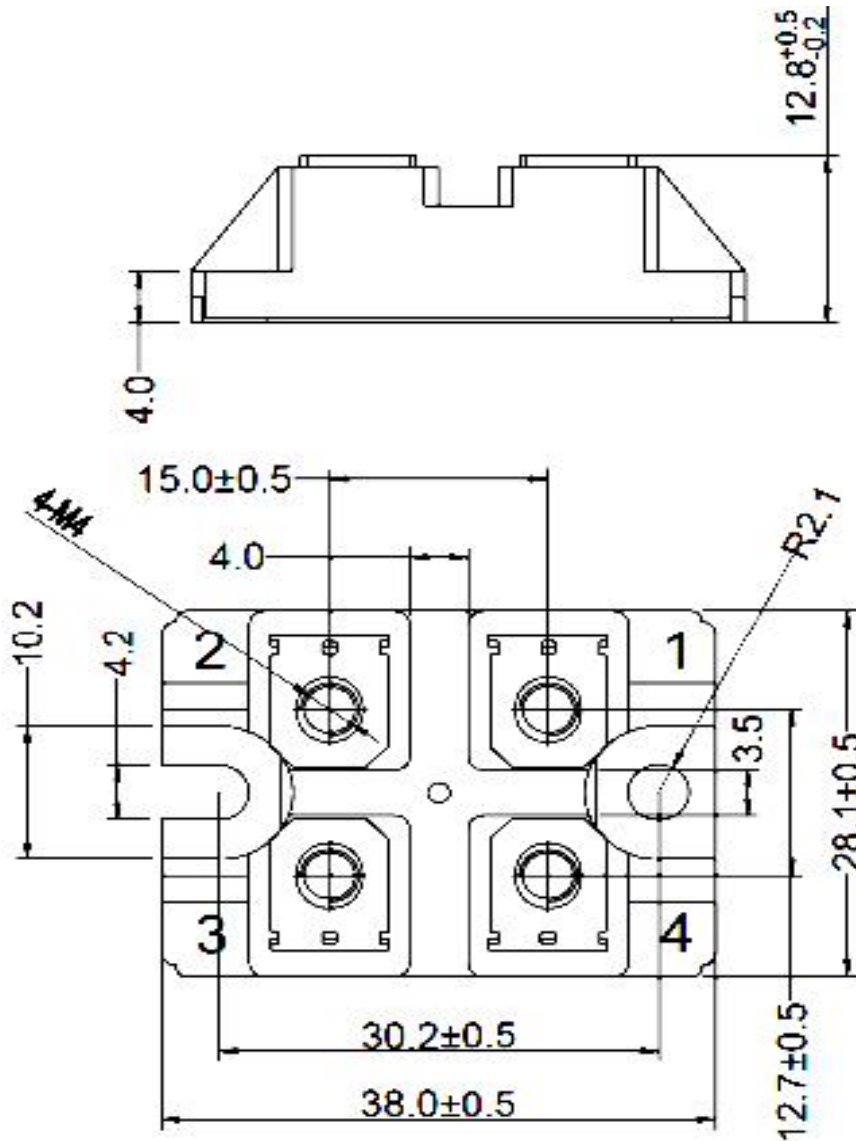
 Fig.8 Typical gate charge characteristic, $V_{GS} = f(Q_G)$

 图 9. 体二极管及第三象限输出特性典型曲线, $I_D = f(V_{DS})$

 Fig.9 Typical body diode output and 3rd quadrant characteristic, $I_D = f(V_{DS})$

Package Dimensions: S O T - 2 2 7


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V2.1 20231011